# onsemi

# MOSFET – Dual, N-Channel, POWERTRENCH<sup>®</sup>, SyncFET™

# FDS6900AS, FDS6900AS-G

#### **General Description**

The FDS6900AS is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous dc-dc power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. FDS6900AS contains two unique 30 V, N-channel, logic level, POWERTRENCH MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the lowside switch (Q2) is optimized to reduce conduction losses. Q2 also includes an integrated Schottky diode using **onsemi**'s monolithic SyncFET technology.

#### Features

- Q2: Optimized to Minimize Conduction Losses Includes SyncFET Schottky Body Diode, 8.2 A, 30 V
  - $R_{DS(on)} = 22 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}$
  - $R_{DS(on)} = 28 \text{ m}\Omega \text{ at } V_{GS} = 4.5 \text{ V}$
- Q1: Optimized for Low Switching Losses Low Gate Charge (11 nC typical), 6.9 A, 30 V
  - $R_{DS(on)} = 27 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}$
  - $R_{DS(on)} = 34 \text{ m}\Omega \text{ at } V_{GS} = 4.5 \text{ V}$
- 100% R<sub>G</sub> (Gate Resistance) Tested
- These Devices are Pb-Free and are RoHS Compliant

#### Specifications

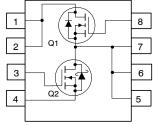
#### **ABSOLUTE MAXIMUM RATINGS** (T<sub>A</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Q2	Q1	Units			
V <sub>DSS</sub>	Drain-Source Voltage	30 30		V			
$V_{GSS}$	Gate-Source Voltage	±20	±20 ±20				
I <sub>D</sub>	Drain Current – Continuous (Note 1a) – Pulsed	8.2 30	6.9 20	A			
PD	Power Dissipation for Dual Operation	2		W			
	Power Dissipation for Single Operation (Note 1a) (Note 1b) (Note 1c)	1.6 1 0.9					
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range	–55 to	-55 to +150				

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### **ELECTRICAL CONNECTION**



Dual N-Channel SyncFet

#### MARKING DIAGRAM



FDS6900AS = Specific Device Code
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A I

YW

- = Assembly Site
- = Wafer Lot Number
- = Assembly Start Week

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
FDS6900AS	SOIC8 (Pb-Free)	2,500 / Tape & Reel
FDS6900AS-G	SOIC8 (Pb–Free)	2,500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Units
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	40	°C/W

# Table 1. ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = $25^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Conditions	Туре	Min	Тур	Max	Units		
OFF CHARACTERISTICS									
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$\begin{split} I_D = 1 \ mA, \ V_{GS} = 0 \ V \\ I_D = 250 \ \mu A, \ V_{GS} = 0 \ V \end{split}$	Q2 Q1	30 30			V		
$\Delta {\rm BV}_{\rm DSS}  / \ \Delta {\rm T}_{\rm J}$	Breakdown Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to 25°C $I_D = 250 \ \mu$ A, referenced to 25°C	Q2 Q1		27 22		mV/°C		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ = 24 V, $V_{GS}$ = 0 V	Q2 Q1			500 1	μΑ		
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{GS}=\pm 20~V,~V_{DS}=0~V$	Q2 Q1			±100	nA		

#### ON CHARACTERISTICS (Note 2)

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_D$ = 1 mA $V_{GS}$ = $V_{DS}$ , $I_D$ = 250 $\mu$ A	Q2 Q1	1 1	1.9 1.9	3 3	V
${\Delta V_{GS(th)} \over \Delta T_J}$ /	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to 25°C $I_D = 250 \ \mu$ A, referenced to 25°C	Q2 Q1		-3.2 -4.2		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$\begin{split} & V_{GS} = 10 \; V, \; I_{D} = 8.2 \; A \\ & V_{GS} = 10 \; V, \; I_{D} = 8.2 \; A, \; T_{J} = 125^\circ C \\ & V_{GS} = 4.5 \; V, \; I_{D} = 7.6 \; A \\ & V_{GS} = 10 \; V, \; I_{D} = 6.9 \; A \\ & V_{GS} = 10 \; V, \; I_{D} = 6.9 \; A \\ & V_{GS} = 10 \; V, \; I_{D} = 6.9 \; A, \; T_{J} = 125^\circ C \\ & V_{GS} = 4.5 \; V, \; I_{D} = 6.2 \; A \end{split}$	Q2 Q1		17 23 21 22 30 27	22 36 28 27 38 34	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS}$ = 10 V, $V_{DS}$ = 5 V	Q2 Q1	30 20			A
9FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 8.2 \text{ A}$ $V_{DS} = 5 \text{ V}, \text{ I}_{D} = 6.9 \text{ A}$	Q2 Q1		25 21		S

#### DYNAMIC CHARACTERISTICS

C <sub>iss</sub>	Input Capacitance	$V_{DS}$ = 15 V, $V_{GS}$ = 0 V, f = 1 MHz	Q2	570		pF
			Q1	600		
C <sub>oss</sub>	Output Capacitance		Q2	180		pF
			Q1	150		
C <sub>rss</sub>	Reverse Transfer Capacitance		Q2	70		pF
			Q1	70		
R <sub>G</sub>	Gate Resistance		Q2	2.8	4.9	Ω
			Q1	2.2	3.8	

#### SWITCHING CHARACTERISTICS (Note 2)

t <sub>d(on)</sub>	Turn-On Delay Time	$\begin{array}{l} V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A}, \text{ V}_{GS} = 10 \text{ V}, \\ \text{R}_{GEN} = 6 \ \Omega \end{array}$	Q2 Q1	10 9	19 18	ns
t <sub>r</sub>	Turn–On Rise Time		Q2 Q1	5 4	10 8	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		Q2 Q1	26 23	42 32	ns
t <sub>f</sub>	Turn-Off Fall Time		Q2 Q1	3 3	6 6	ns

#### Table 1. ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Conditions	Туре	Min	Тур	Max	Units
SWITCHING	CHARACTERISTICS (Note 2)						
t <sub>d(on)</sub>	Turn-On Delay Time	$\label{eq:VDD} \begin{array}{l} V_{DD} = 15 \; V, \; I_{D} = 1 \; A, \; V_{GS} = 4.5 \; V, \\ R_{GEN} = 6 \; \Omega \end{array}$	Q2 Q1		11 10	20 19	ns
t <sub>r</sub>	Turn–On Rise Time		Q2 Q1		15 9	27 18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		Q2 Q1		16 14	29 25	ns
t <sub>f</sub>	Turn-Off Fall Time		Q2 Q1		6 4	12 8	ns
Q <sub>g(TOT)</sub>	Total Gate Charge at $V_{GS}$ = 10 V	Q2: $V_{DS} = 15 \text{ V}$ , $I_D = 8.2 \text{ A}$ Q1: $V_{DS} = 15 \text{ V}$ , $I_D = 6.9 \text{ A}$	Q2 Q1		10 11	15 15	nC
Qg	Total Gate Charge at $V_{GS}$ = 5 V		Q2 Q1		5.8 6.1	8.2 8.5	nC
Q <sub>gs</sub>	Gate-Source Charge		Q2 Q1		1.6 1.7		nC
Q <sub>gd</sub>	Gate-Drain Charge		Q2 Q1		2.1 2.2		nC

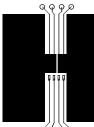
#### DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current		Q2 Q1		2.3 1.3	A
T <sub>rr</sub>	Reverse Recovery Time	$I_F = 8.2 \text{ A}, d_{iF}/d_t = 300 \text{ A}/\mu\text{s}$	Q2	15		ns
Q <sub>rr</sub>	Reverse Recovery Charge	(Note 3)		6		nC
T <sub>rr</sub>	Reverse Recovery Time	$I_F = 6.9 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu \text{s}$	Q1	19		ns
Q <sub>rr</sub>	Reverse Recovery Charge	(Note 3)		10		nC
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$\begin{split} V_{GS} &= 0V, \ I_S = 2.3 \ A \ (Note \ 2) \\ V_{GS} &= 0V, \ I_S = 5 \ A \ (Note \ 2) \\ V_{GS} &= 0V, \ I_S = 1.3 \ A \ (Note \ 2) \end{split}$	Q2 Q2 Q1	0.6 0.7 0.7	0.7 1.0 1.2	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### NOTES:

1. R<sub>0,JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a. 78°C/W when mounted on a 0.5 in<sup>2</sup> pad of 2 oz copper.



b. 125°C/W when mounted on 6 6 6 6 a 0.02 in<sup>2</sup> pad of 2 oz copper.

c. 135°C/W when mounted on o o o o a minimum pad

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2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.

3. See "SyncFET Schottky body diode characteristics" below.

#### **TYPICAL CHARACTERISTICS: Q2**

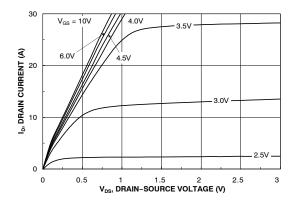
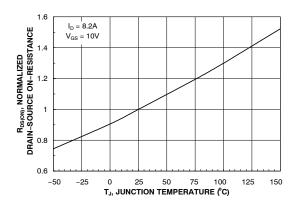
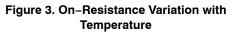


Figure 1. On–Region Characteristics





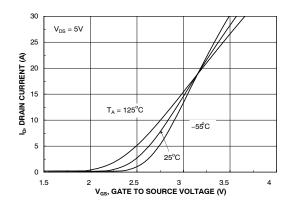


Figure 5. Transfer Characteristics

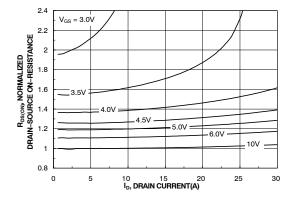


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

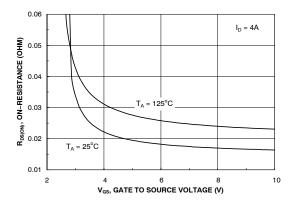


Figure 4. On–Resistance Variation with Gate–to–Source Voltage

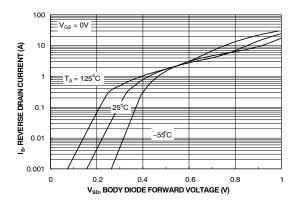


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

#### TYPICAL CHARACTERISTICS: Q2 (Continued)

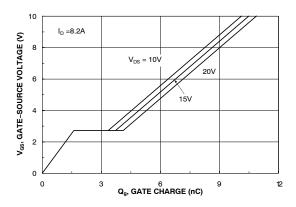


Figure 7. Gate Charge Characteristics

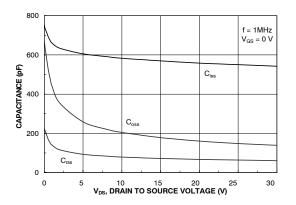


Figure 8. Capacitance Characteristics

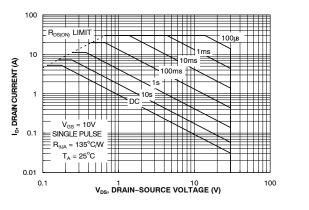


Figure 9. Maximum Safe Operating Area

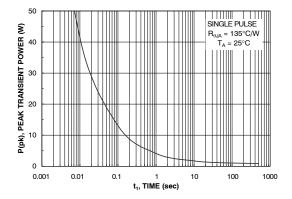


Figure 10. Single Pulse Maximum Power Dissipation

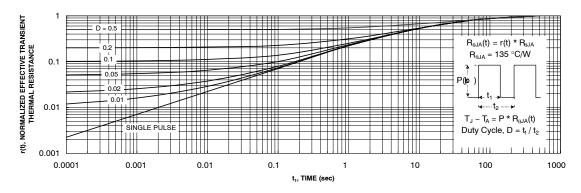


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

#### **TYPICAL CHARACTERISTICS: Q1**

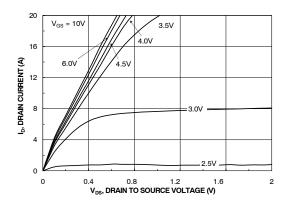
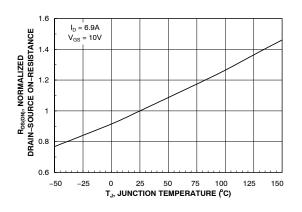
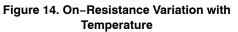


Figure 12. On-Region Characteristics





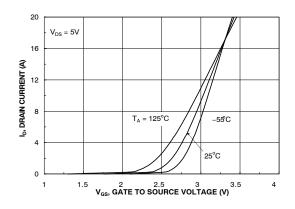


Figure 16. Transfer Characteristics

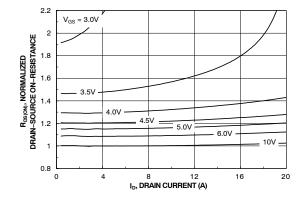
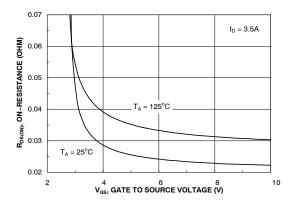


Figure 13. On–Resistance Variation with Drain Current and Gate Voltage





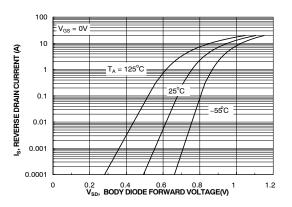


Figure 17. Body Diode Forward Voltage Variation with Source Current and Temperature

#### TYPICAL CHARACTERISTICS: Q1 (Continued)

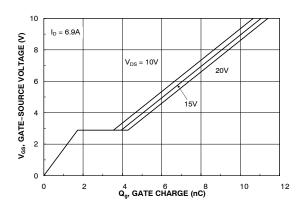


Figure 18. Gate Charge Characteristics

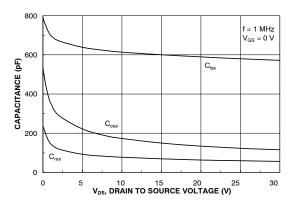


Figure 19. Capacitance Characteristics

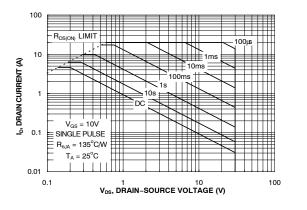


Figure 20. Maximum Safe Operating Area

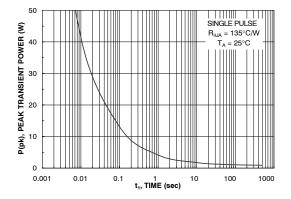
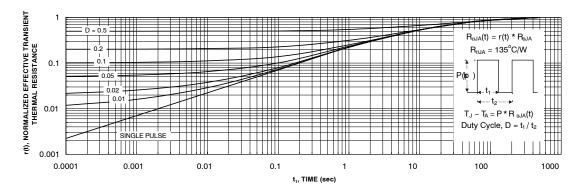


Figure 21. Single Pulse Maximum Power Dissipation



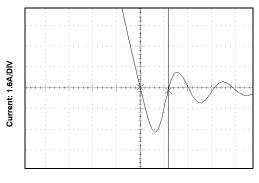


Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

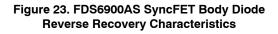
#### TYPICAL CHARACTERISTICS (Continued)

#### SyncFET Schottky Body Diode Characteristics

**onsemi**'s SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 23 shows the reverse recovery characteristic of the FDS6900AS.



Time: 10nS/DIV



For comparison purposes, Figure 24 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6690).

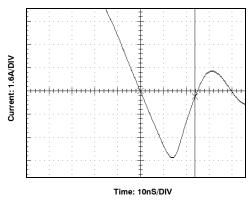


Figure 24. Non–SyncFET (FDS6690) Body Diode Reverse Recovery Characteristics

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

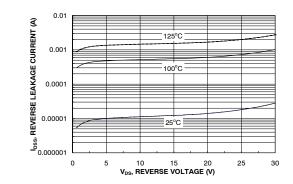


Figure 25. SyncFET Body Diode Reverse Leakage versus Drain–Source Voltage and Temperature

### TYPICAL CHARACTERISTICS (Continued)

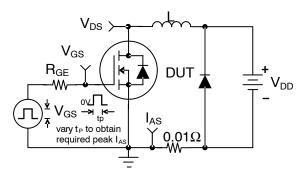


Figure 26. Unclamped Inductive Load Test Circuit

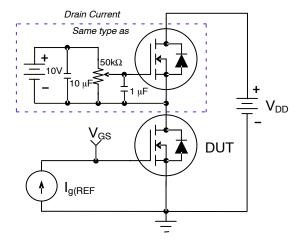


Figure 28. Gate Charge Test Circuit

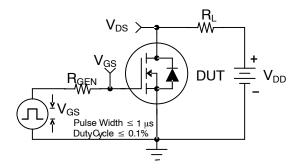


Figure 30. Switching Time Test Circuit

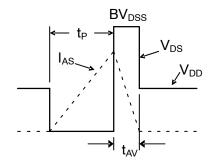


Figure 27. Unclamped Inductive Waveforms

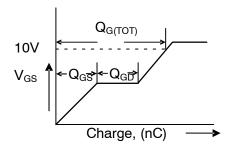


Figure 29. Gate Charge Waveform

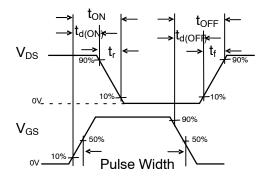
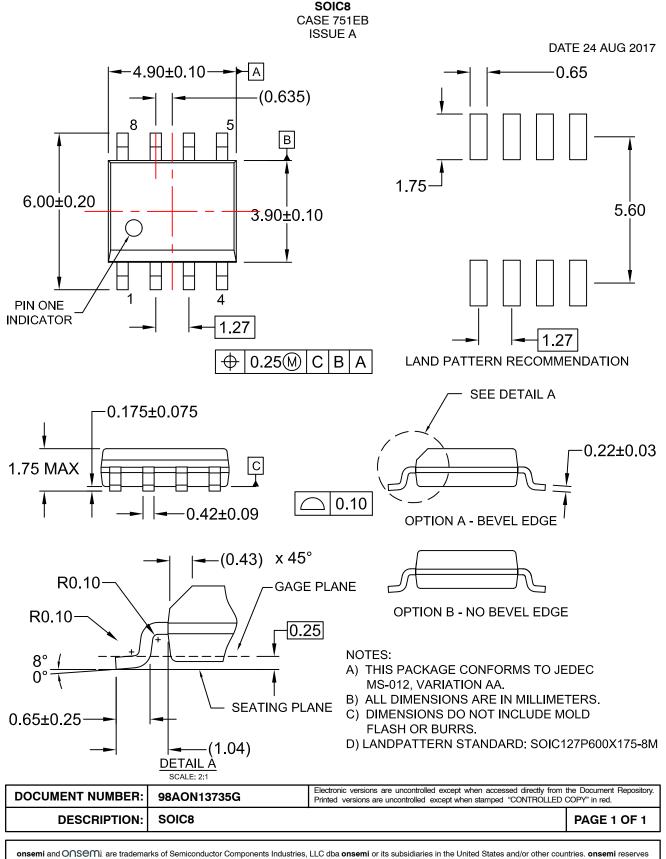


Figure 31. Switching Time Waveform

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